## 2. Chemical vapour deposition (CVD)

In the chemical vapour deposition process (CVD), gaseous species are produced independently and react, after mixing, in a deposition chamber.

*Figure.22 Chemical vapour deposition (CVD) of Nb<sub>3</sub>Ge films.* 



This process is illustrated by the synthesis

of Nb<sub>3</sub>Ge films (figure 22). Hydrogen reduction of the chlorides is performed at T=900  $^{\circ}$ C, according to the reaction :

$$3NbCl_3 + GeCl_4 + 6.5H_2 \stackrel{\leftarrow}{\rightarrow} Nb_3Ge + 13HCl$$

An argon flow dilutes the NbCl<sub>3</sub>, GeCl<sub>4</sub> and H<sub>2</sub> gases. Chlorides are prepared in a first step by the reactions :

$$3Nb + 4.5Cl_2 \xrightarrow{\approx 300^{\circ}C} 3NbCl_3$$
$$Ge + 2Cl_2 \xrightarrow{\approx 300^{\circ}C} GeCl_4$$

They are mixed with hydrogen at a temperature (T<500°C) which prevents from the reduction of chlorides to give Nb<sub>3</sub>Ge.

The CVD process allows for the formation of large area films. It is mainly used for semiconductors.

Amorphous hydrogenated silicon was studied for solar applications :

$$\operatorname{SiCl}_4 + 2\operatorname{H}_2 + \varepsilon(\operatorname{PH}_3 \text{ or } 0.5\operatorname{B}_2\operatorname{H}_6) \xrightarrow{1100^\circ \mathrm{C}} \operatorname{Si} : (\operatorname{H} + \operatorname{Por} \mathrm{B}) + (4 + 3\varepsilon)\mathrm{HCl}$$

Silicides exhibit very promising properties for electronic, optical and magnetic component integration :  $CoSi_2$ ,  $WSi_2$ ,  $FeSi_2$ . They are grown by vapour phase epitaxy ; the crystalline films are preferentially oriented with respect to the substrate of silicon (111) wafers.

The formation of WSi<sub>2</sub> results from the reaction of SiH<sub>4</sub> silane with WCl<sub>4</sub> :

$$WCl_4 + 2SiH_4 \rightarrow WSi_2 + 2H_2 + 4HCl$$

The partial pressure of WCl<sub>4</sub> is controlled by the chlorine flow and by the temperature in the chlorination chamber :  $W + 2Cl_2 \rightarrow WCl_4(g)$ .

The CVD phase diagram WCl<sub>4</sub>-SiCl<sub>4</sub> (figure 23) shows that pure WSi<sub>2</sub> forms, at T=500  $^{\circ}$ C, in a narrow composition range.

A lot of work has been devoted recently to the growth of diamond films. Such films have attracted attention for their expected high hardness, electrical resistivity, thermal conduction and optical transparency. They are formed by decomposition of methane or acetylene in the presence of  $H_2$  and small amounts of  $O_2$ ,  $H_2O$  or  $CO_2$  in a microwave plasma (2.456 GHz, 1 kW) :

$$CH_{4} \xrightarrow{H_{2}+\varepsilon(CO_{2}+H_{2}O+O_{2})} C_{4} + 2H_{2}$$

The substrate is heated at 500 °C<T<700 °C; the total pressure is P≈2000 Pa and the volume ratio  $V_{CH_4}/V_{H_2}$  lies in the range 3-10 %. Stepped growth with (111) and (100) faces indicates surface diffusion. However, the growth mechanism, very slow, is not yet well understood. Heterogeneous nucleation on the surface defects (scratches ...) occurs in a first step and the growth rate is very slow : 1 µm per hour or 0.1 g h<sup>-1</sup> on a silicon wafer of  $\phi=20$  cm



WSi<sub>2</sub> + Si

0.008

X<sub>SiH4</sub>

diameter (a layer of 4H-SiC forms at the interface). Diamond coating of high specific area fibres or grids was recently achieved and a mass increase of 5-10 g.h<sup>-1</sup> was observed on a grid of 200000 wires ( $\phi$ =10 µm, l=50 mm).

0.002

0.002

0.004

0.006

It is interesting to note that nanometer size diamond crystals (cubic diamond or hexagonal londsaleite), associated with SiC, are thought to have formed by a CVD process from the ejecta plumes of large meteorite impacts (Ries crater in Germany).

Numerous variants of the CVD method have been devised. They differ from the heating mode : hot filament, DC or microwave plasma PECVD (plasma-enhanced), from the source of gaseous species : OMCVD (organometallic) or from the synthesis conditions : LPCVD (low pressure).

## 3. Molecular beam epitaxy and related techniques.

Thin films are deposited on substrates in ultrahigh vacuum ( $10^{-6}$  Pa). Several methods of material evaporation are used :

- effusion in ovens (Knudsen cells) operating at high temperature (1200-1400 °C for CaF<sub>2</sub> coating on (111)Si);
- pulsed Laser heating of targets (high T<sub>c</sub> superconductor Hg-1212, HgBa<sub>2</sub>CaCu<sub>2</sub>O<sub>6+δ</sub>, deposited from HgO and Ba<sub>2</sub>CaCu<sub>2</sub>O<sub>x</sub> sources on (100) oriented SrTiO<sub>3</sub> substrate);
- electron beam heating (Si and III-V compounds deposition).

Pressures of approximately 10<sup>-5</sup> Pa are usually maintained during deposition. Very thin layers, down to the atomic scale, can be obtained. Alternation of layer composition allows to build unknown structures in the bulk.

Figure 23. - Phase stability in the CVD diagram W-Si-Cl-H.